

Dual Enhancement Mode MOSFET (N- and P-Channel)

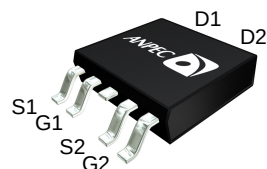
Features

- N-Channel
40V/7.5A,
 $R_{DS(ON)} = 25m\Omega$ (typ.) @ $V_{GS} = 10V$
 $R_{DS(ON)} = 35m\Omega$ (typ.) @ $V_{GS} = 4.5V$
- P-Channel
-40V/-6A,
 $R_{DS(ON)} = 37m\Omega$ (typ.) @ $V_{GS} = -10V$
 $R_{DS(ON)} = 49m\Omega$ (typ.) @ $V_{GS} = -4.5V$
- Super High Dense Cell Design
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

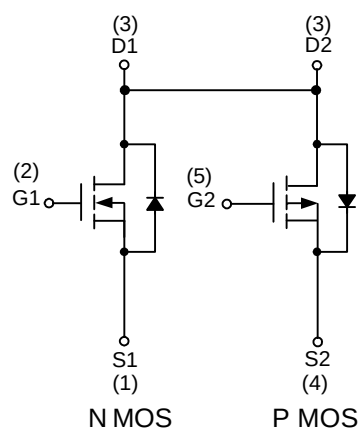
Applications

- Power Management in LCD monitor/TV

Pin Description



Top View of TO-252-4



Ordering and Marking Information

APM4048D □□□-□□□ Assembly Material Handling Code Temperature Range Package Code	Package Code U4 : TO-252-4 Operating Junction Temperature Range C : -55 to 150 °C Handling Code TR : Tape & Reel Assembly Material G : Halogen and Lead Free Device
APM4048D U4 : 	XXXXX - Date Code

Note: ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020C for MSL classification at lead-free peak reflow temperature. ANPEC defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings (T_A = 25°C unless otherwise noted)

Symbol	Parameter		Rating		Unit
			N Channel	P Channel	
V _{DSS}	Drain-Source Voltage		40	-40	V
V _{GSS}	Gate-Source Voltage		±20	±20	
I _D ^a	Continuous Drain Current	T _C =25°C	7.5 ^b	-6 ^b	A
I _{DM} ^a	Pulsed Drain Current	T _C =25°C	30	-20	
I _S ^a	Diode Continuous Forward Current	T _C =25°C	7.5 ^b	-6 ^b	A
T _J	Maximum Junction Temperature		150		°C
T _{STG}	Storage Temperature Range		-55 to 150		
P _D	Power Dissipation	T _C =25°C	25		W
		T _C =100°C	10		
R _{θJC}	Thermal Resistance-Junction to Case		5		°C/W
R _{θJA} ^a	Thermal Resistance-Junction to Ambient		50		°C/W

Note a : Surface Mounted on 1in² pad area, t ≤ 10sec.

Note b : Current limited by bond wire.

Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions		APM4048DU4			Unit
				Min.	Typ.	Max.	
Static Characteristics							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	N-Ch	40	-	-	V
		V _{GS} =0V, I _{DS} =-250μA	P-Ch	-40	-	-	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =32V, V _{GS} =0V	N-Ch	-	-	1	μA
		T _J =85°C		-	-	30	
		V _{DS} =-32V, V _{GS} =0V	P-Ch	-	-	-1	
		T _J =85°C		-	-	-30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	N-Ch	1.3	2.1	2.5	V
		V _{DS} =V _{GS} , I _{DS} =-250μA	P-Ch	-1.3	-1.9	-2.5	
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	N-Ch	-	-	±100	nA
		V _{GS} =±20V, V _{DS} =0V	P-Ch	-	-	±100	
R _{DS(ON)} ^a	Drain-Source On-State Resistance	V _{GS} =10V, I _{DS} =7.5A	N-Ch	-	25	33	mΩ
		V _{GS} =-10V, I _{DS} =-6A	P-Ch	-	37	48	
		V _{GS} =4.5V, I _{DS} =5A	N-Ch	-	35	45	
		V _{GS} =-4.5V, I _{DS} =-3.5A	P-Ch	-	49	68	

Electrical Characteristics (Cont.) (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	APM4048DU4			Unit	
			Min.	Typ.	Max.		
Diode Characteristics							
V _{SD} ^a	Diode Forward Voltage	I _{SD} =2A, V _{GS} =0V	N-Ch	-	0.8	1.1	V
		I _{SD} =-2A, V _{GS} =0V	P-Ch	-	-0.8	-1.1	
Dynamic Characteristics ^b							
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	N-Ch	-	1.5	-	Ω
			P-Ch	-	6.8	-	
C _{iss}	Input Capacitance	N-Channel V _{GS} =0V, V _{DS} =20V, Frequency=1.0MHz	N-Ch	-	950	-	pF
C _{oss}	Output Capacitance		P-Ch	-	1110	-	
			N-Ch	-	115	-	
C _{rss}	Reverse Transfer Capacitance		P-Ch	-	125	-	
		N-Ch	-	75	-		
t _{d(ON)}	Turn-on Delay Time	N-Channel V _{DD} =20V, R _L =20Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	P-Ch	-	70	-	ns
			N-Ch	-	13	25	
P-Ch	-		8	17			
t _r	Turn-on Rise Time		N-Ch	-	10	19	
			P-Ch	-	12.5	24	
t _{d(OFF)}	Turn-off Delay Time		N-Ch	-	27	50	
			P-Ch	-	40	73	
t _f	Turn-off Fall Time		N-Ch	-	5	10	
		P-Ch	-	15	28		
t _{rr}	Reverse Recovery Time	N-Channel I _{SD} =7.5A, dI _{SD} /dt =100A/μs	N-Ch	-	20	-	ns
			P-Ch	-	19	-	
Q _{rr}	Reverse Recovery Charge	P-Channel I _{SD} =-6A, dI _{SD} /dt =100A/μs	N-Ch	-	13	-	nC
			P-Ch	-	12	-	
Gate Charge Characteristics ^b							
Q _g	Total Gate Charge	N-Channel V _{DS} =20V, V _{GS} =10V, I _{DS} =7.5A	N-Ch	-	17.2	33	nC
			P-Ch	-	17.5	34.5	
Q _{gs}	Gate-Source Charge	P-Channel V _{DS} =-20V, V _{GS} =-10V, I _{DS} =-6A	N-Ch	-	3.5	-	
			P-Ch	-	2.8	-	
Q _{gd}	Gate-Drain Charge		N-Ch	-	5.3	-	
			P-Ch	-	4	-	

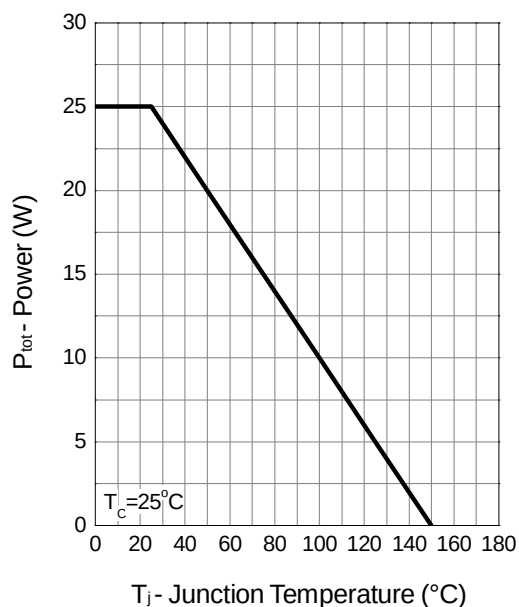
Note a : Pulse test ; pulse width≤300μs, duty cycle≤2%.

Note b : Guaranteed by design, not subject to production testing.

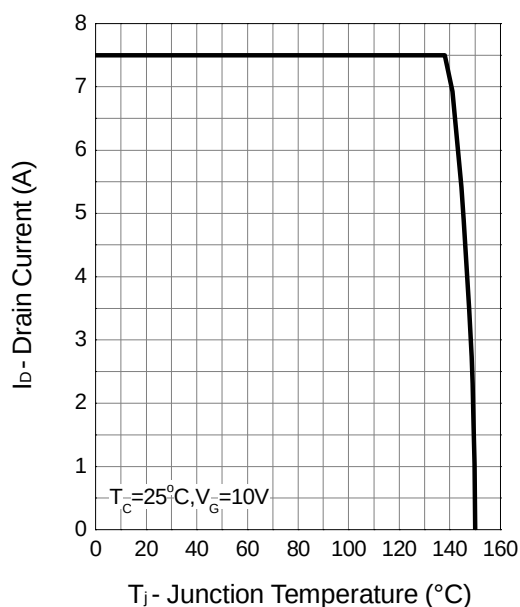
Typical Operating Characteristics

N-Channel

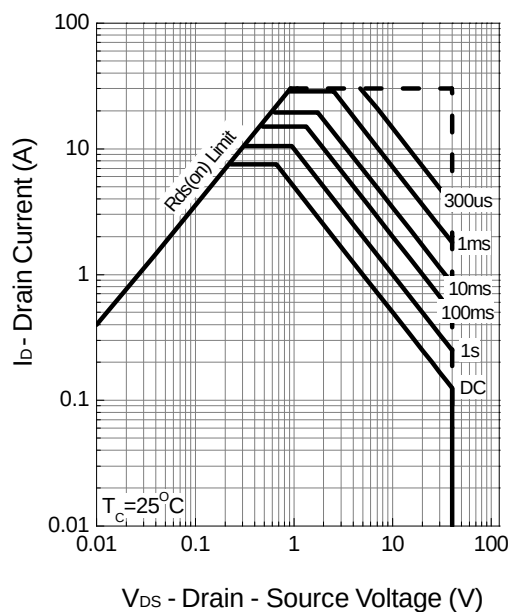
Power Dissipation



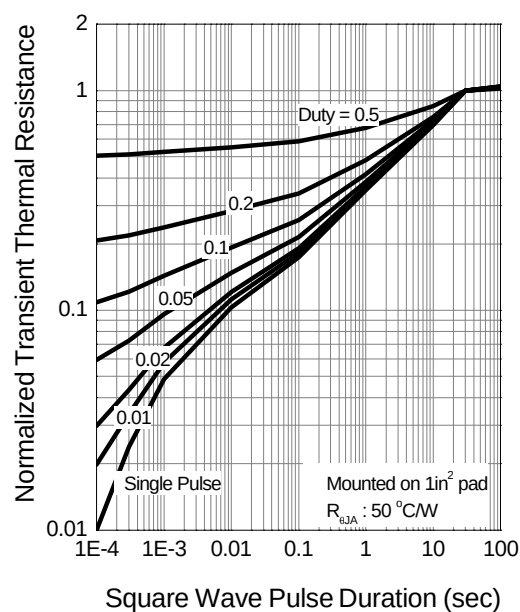
Drain Current



Safe Operation Area



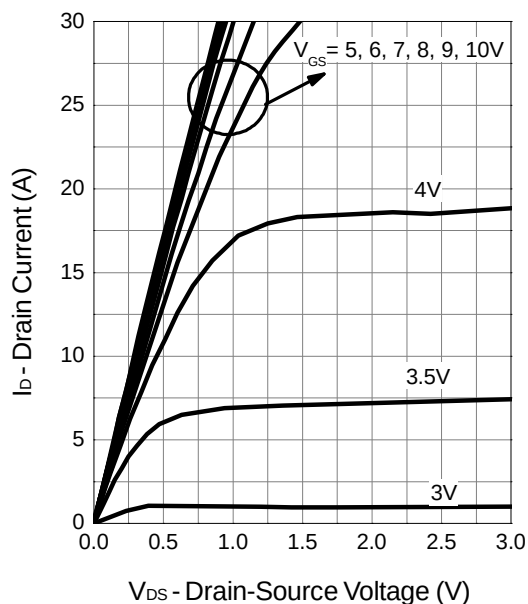
Thermal Transient Impedance



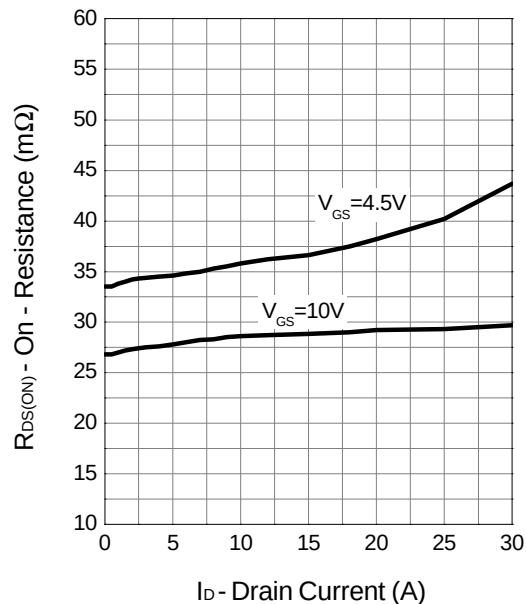
Typical Operating Characteristics (Cont.)

N-Channel

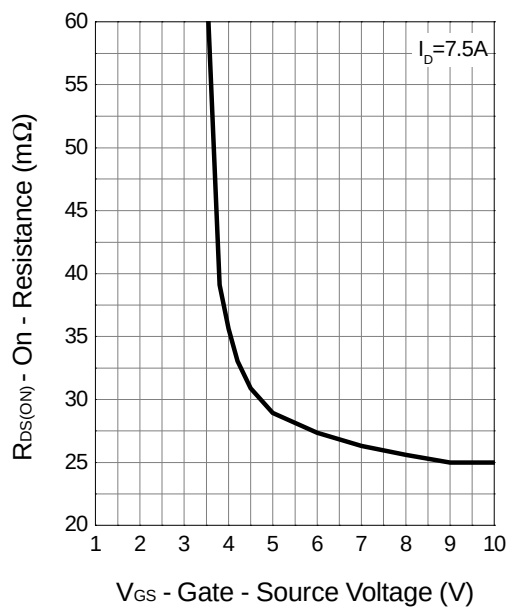
Output Characteristics



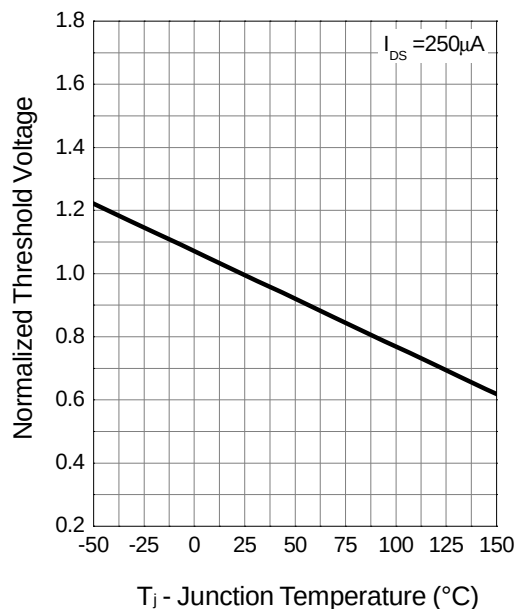
Drain-Source On Resistance



Gate-Source On Resistance



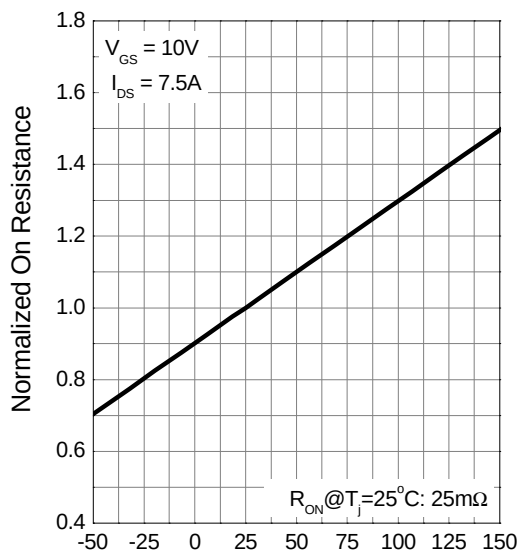
Gate Threshold Voltage



Typical Operating Characteristics (Cont.)

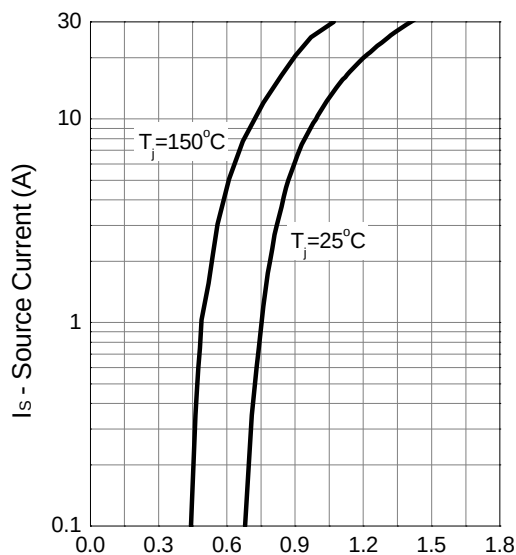
N-Channel

Drain-Source On Resistance



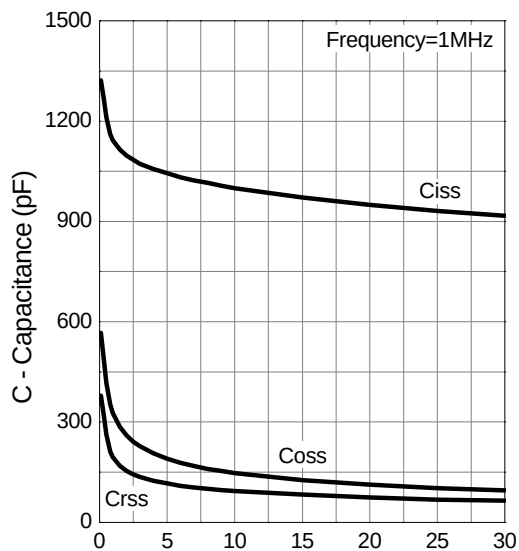
T_j - Junction Temperature ($^{\circ}\text{C}$)

Source-Drain Diode Forward



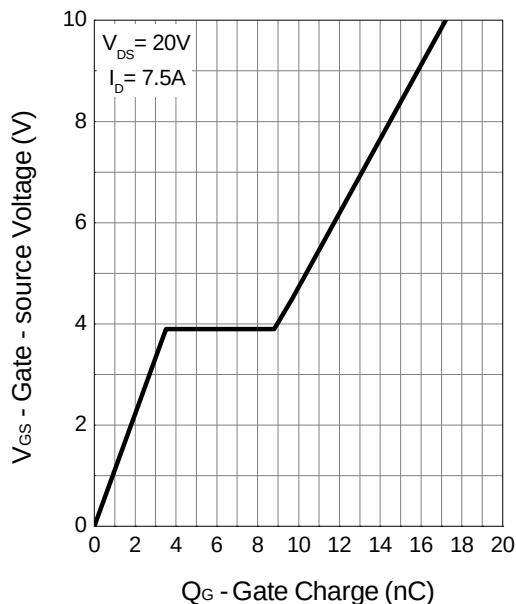
V_{SD} - Source - Drain Voltage (V)

Capacitance



V_{DS} - Drain - Source Voltage (V)

Gate Charge

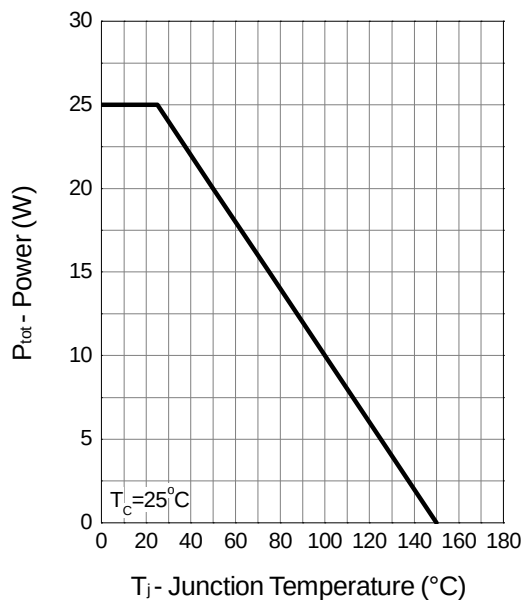


Q_G - Gate Charge (nC)

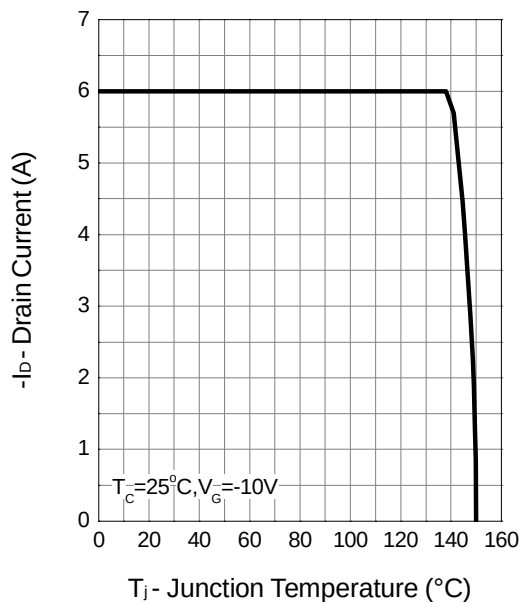
Typical Operating Characteristics (Cont.)

P-Channel

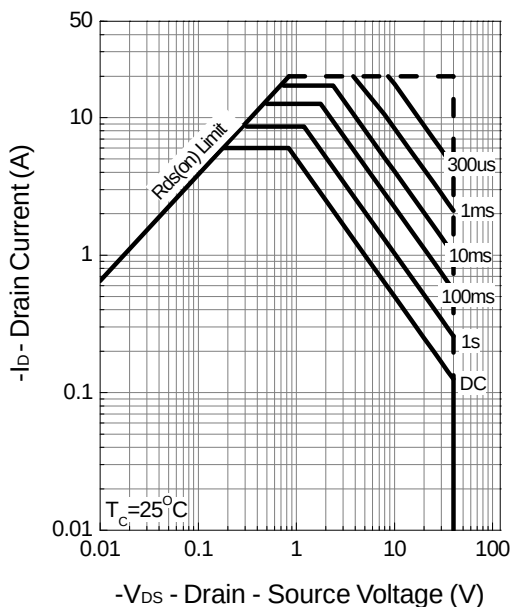
Power Dissipation



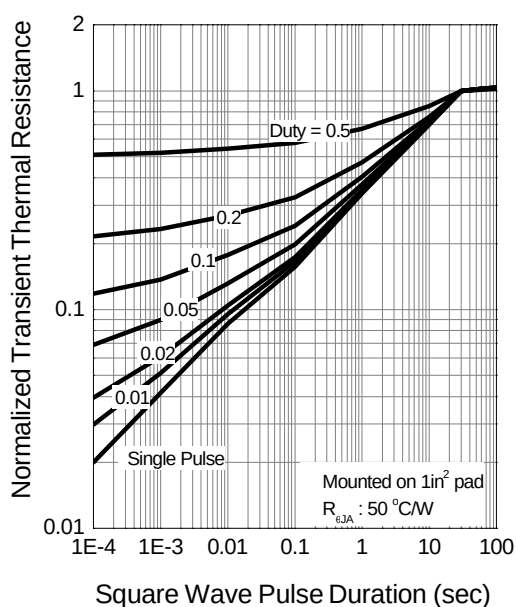
Drain Current



Safe Operation Area



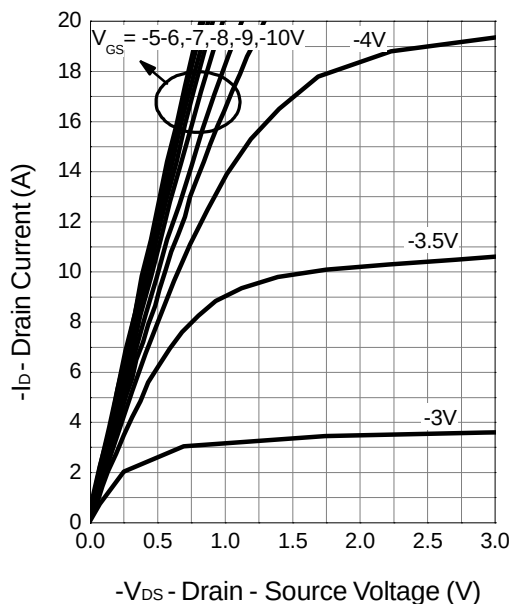
Thermal Transient Impedance



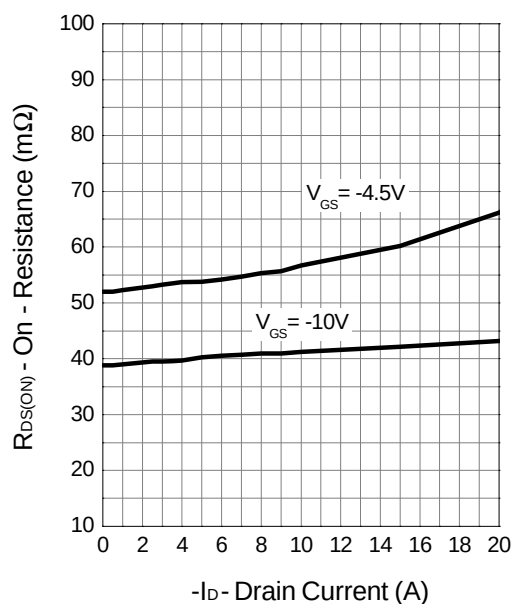
Typical Operating Characteristics (Cont.)

P-Channel

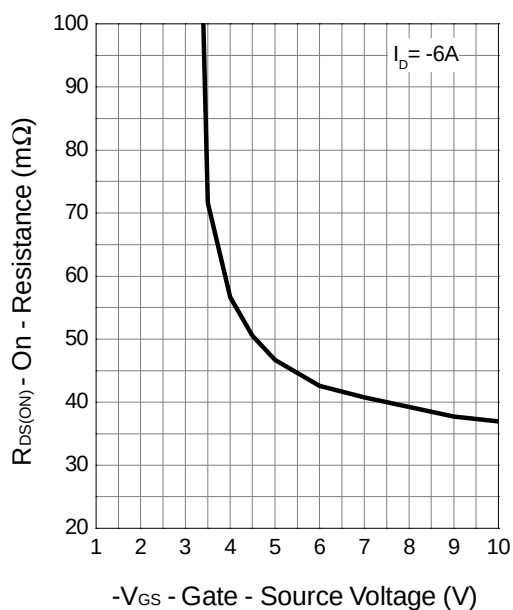
Output Characteristics



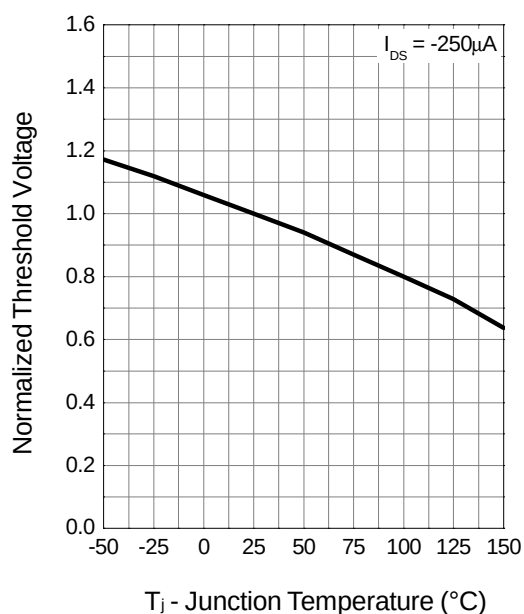
Drain-Source On Resistance



Gate-Source On Resistance



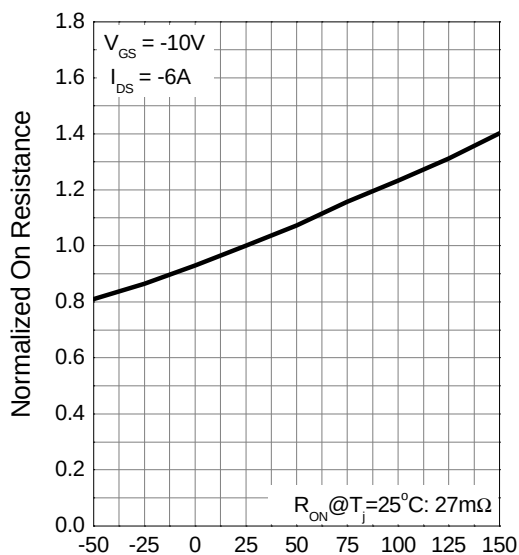
Gate Threshold Voltage



Typical Operating Characteristics (Cont.)

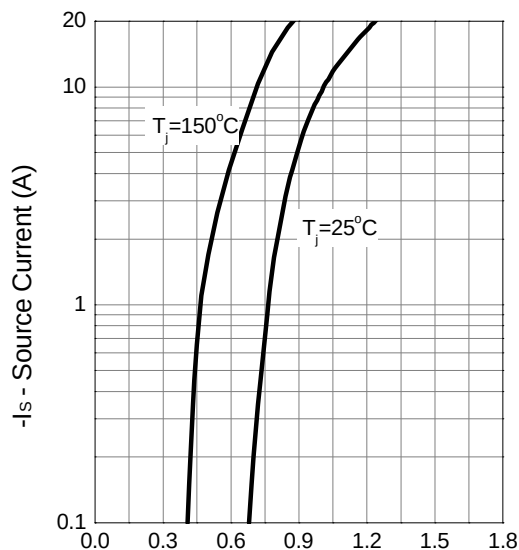
P-Channel

Drain-Source On Resistance



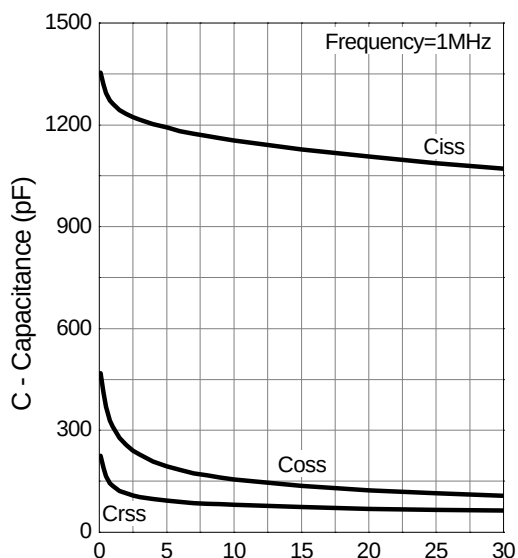
T_j - Junction Temperature ($^\circ C$)

Source-Drain Diode Forward



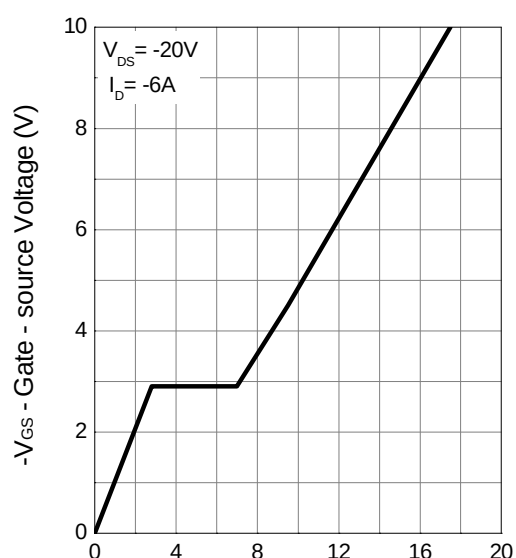
$-V_{SD}$ - Source - Drain Voltage (V)

Capacitance



$-V_{DS}$ - Drain - Source Voltage (V)

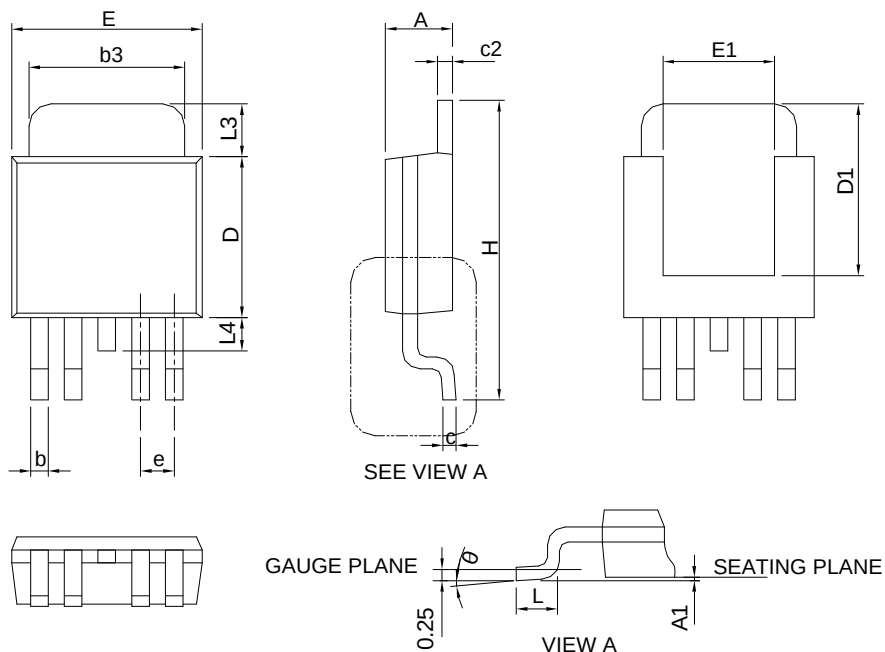
Gate Charge



Q_G - Gate Charge (nC)

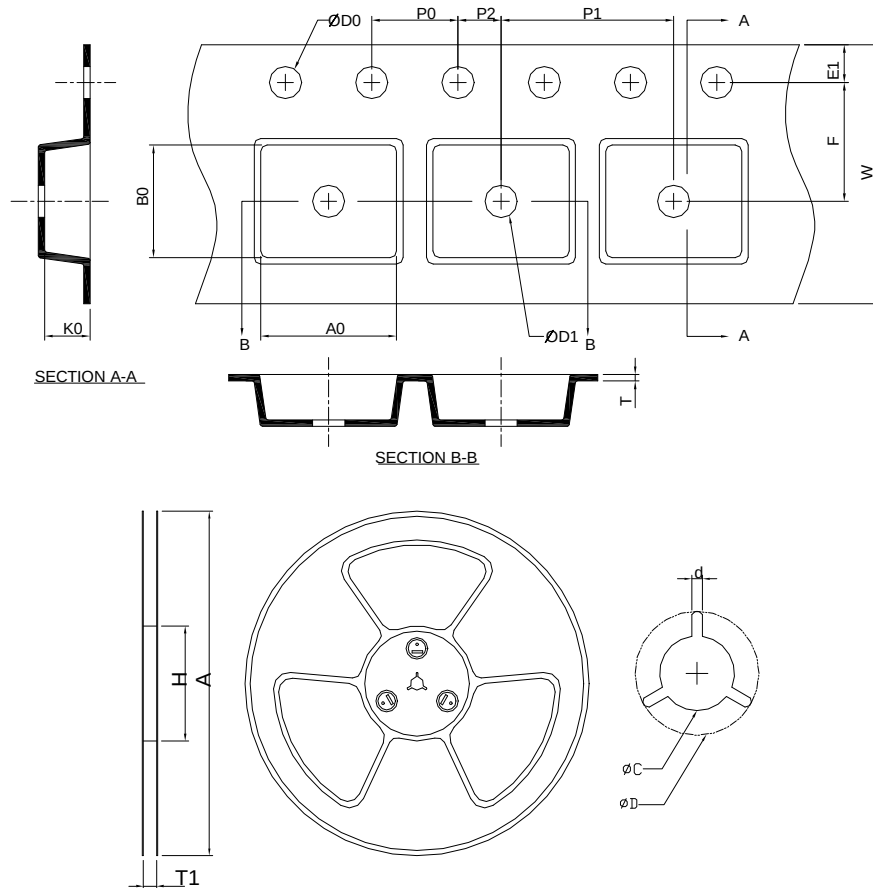
Package Information

TO-252-4



SYMBOL	TO-252-4			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	0.086	0.094
A1		0.13		0.005
b	0.50	0.71	0.020	0.028
b3	4.32	5.46	0.170	0.215
c	0.46	0.61	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.33	6.22	0.210	0.245
D1	4.57	6.00	0.180	0.236
E	6.35	6.73	0.250	0.265
E1	3.81	6.00	0.150	0.236
e	1.27 BSC		0.050 BSC	
H	9.40	10.41	0.370	0.410
L	1.40	1.78	0.055	0.070
L3	0.89	2.03	0.035	0.080
L4		1.02		0.040
θ	0°	8°	0°	8°

Carrier Tape & Reel Dimensions



Application	A	H	T1	C	d	D	W	E1	F
TO-252-4	330.0 $\pm$ 2.00	50 MIN.	16.4 $\pm$ 2.00 -0.00	13.0 $\pm$ 0.50 -0.20	1.5 MIN.	20.2 MIN.	16.0 $\pm$ 0.30	1.75 $\pm$ 0.10	7.50 $\pm$ 0.05
	P0	P1	P2	D0	D1	T	A0	B0	K0
	4.0 $\pm$ 0.10	8.0 $\pm$ 0.10	2.0 $\pm$ 0.05	1.5 $\pm$ 0.10 -0.00	1.5 MIN.	0.6 $\pm$ 0.00 -0.40	6.80 $\pm$ 0.20	10.40 $\pm$ 0.20	2.50 $\pm$ 0.20

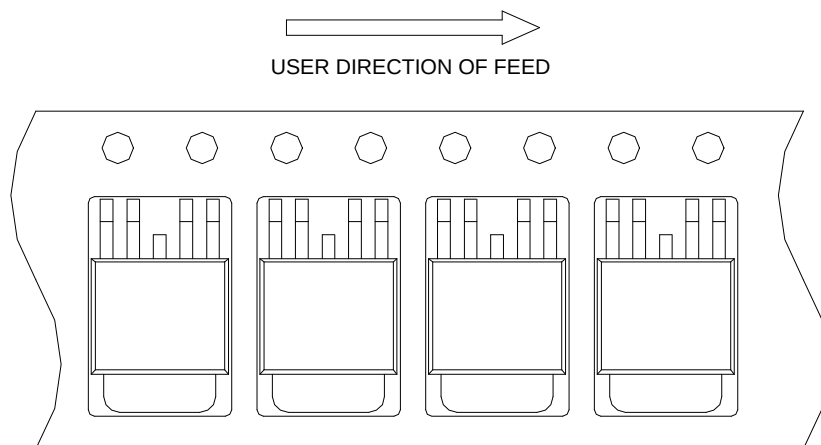
(mm)

Devices Per Unit

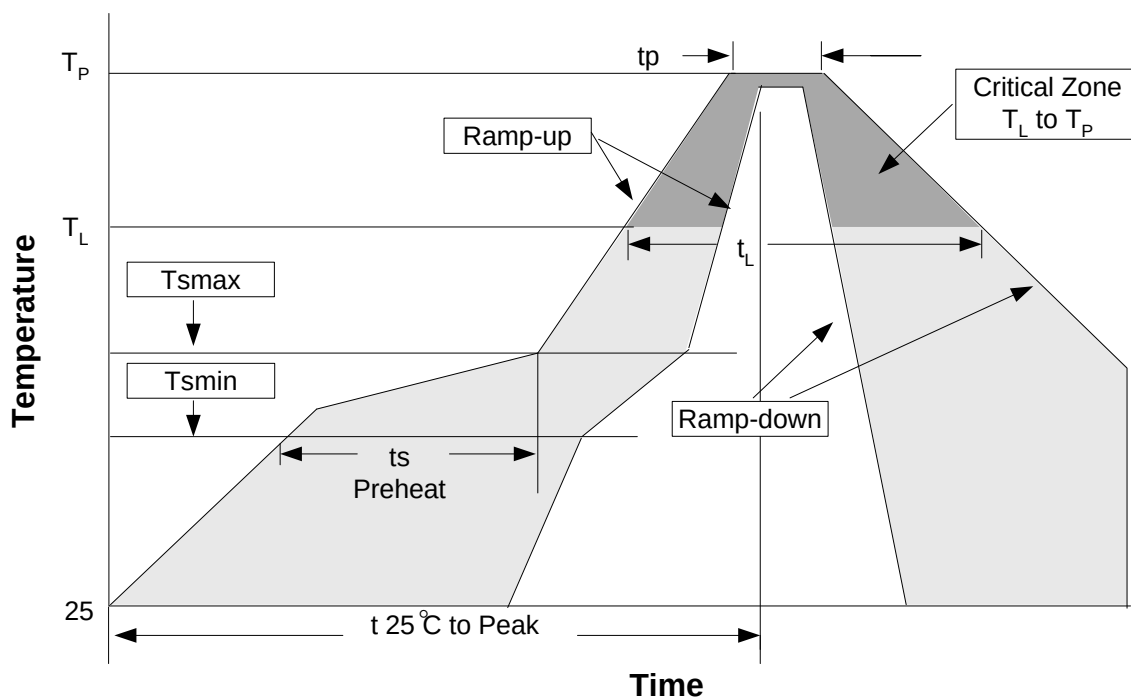
Package Type	Unit	Quantity
TO-252-4	Tape & Reel	2500

Taping Direction Information

TO-252-4



Reflow Condition (IR/Convection or VPR Reflow)



Reliability Test Program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 sec
HOLT	MIL-STD-883D-1005.7	1000 Hrs Bias @125°C
PCT	JESD-22-B, A102	168 Hrs, 100%RH, 121°C
TST	MIL-STD-883D-1011.9	-65°C~150°C, 200 Cycles

Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	3°C/second max.	3°C/second max.
Preheat - Temperature Min (T_{smin}) - Temperature Max (T_{smax}) - Time (min to max) (ts)	100°C 150°C 60-120 seconds	150°C 200°C 60-180 seconds
Time maintained above: - Temperature (T_L) - Time (t_L)	183°C 60-150 seconds	217°C 60-150 seconds
Peak/Classification Temperature (T_P)	See table 1	See table 2
Time within 5°C of actual Peak Temperature (t_P)	10-30 seconds	20-40 seconds
Ramp-down Rate	6°C/second max.	6°C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Note: All temperatures refer to topside of the package. Measured on the body surface.

Table 1. SnPb Eutectic Process – Package Peak Reflow Temperatures

Package Thickness	Volume mm ³ <350	Volume mm ³ 350
<2.5 mm	240 +0/-5°C	225 +0/-5°C
≥2.5 mm	225 +0/-5°C	225 +0/-5°C

Table 2. Pb-free Process – Package Classification Reflow Temperatures

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 +0°C*	260 +0°C*	260 +0°C*
1.6 mm – 2.5 mm	260 +0°C*	250 +0°C*	245 +0°C*
≥2.5 mm	250 +0°C*	245 +0°C*	245 +0°C*

*Tolerance: The device manufacturer/supplier **shall** assure process compatibility up to and including the stated classification temperature (this means Peak reflow temperature +0°C. For example 260°C+0°C) at the rated MSL level.

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